

Notice of References Cited	Application/Control No. 09/365,342		Applicant(s)/Patent Under Reexamination HETZLER ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,205,576 /	03-2001	Rajala et al.	717/105
	C	US-6,154,220 /	11-2000	Prakriya et al.	345/440
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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